

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector

By:

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C O N N E X I O N S

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Chapter 1

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Abstract/Hypotheses¹

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Abstract/Hypotheses

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1. Introduction

Radiation therapy involves treating cancer cells with beams of high-energy particles, such as gamma rays or X-rays. Radiation therapy affects cancer cells by destroying the DNA of the cells. The direct damage is caused by a photon, electron, proton, neutron, or ion beam and the indirect damage is caused by ionizing the atoms which make up the DNA chain. The indirect ionization occurs as a result of the ionization of water, forming free radicals (hydroxyl radicals), which in turn damage the DNA. In most cases the radiation effect is due to free radicals. This is because cells have mechanisms for repairing DNA damage. Since cancer cells cannot be differentiated like stem cell-like, they reproduce rapidly, and have a reduced ability to repair sub-lethal damage when compared to healthy cells. Both healthy and cancerous cells are damaged by radiation; the goal of treatment is to affect as few normal cells as possible. The radiation on healthy cells can be severe, to epithelial surfaces (skin, oral, pharyngeal and bowel mucosa, urothelium), swelling edema or Oedema). In order to reduce the effect of radiation on healthy cells, some of the advanced radiation therapy techniques are designed like Intensity modulated radiation therapy¹ (IMRT), 3-D conformal radiation therapy.

Currently, the radiation received by the tissue is based on initial 3-D view of the tumor. This method doesn't consider the effect of changing tumor size after it has received the radiation due to which the radiation target might have changed. Even with such high sophistication in dose delivery, when the patient moves during receiving the dose the dose is delivered to the healthy tissue. The need for real-time dose monitoring is clearly understood by this problem statement. The Thermo-luminescent dosimeters (TLD's) have been used to measure the radiation received but the main problem of using them is they give a measure of total radiation received by the subject for the duration of the treatment, real-time monitoring is not possible. If a miniature wireless radiation sensing device capable of measuring the radiation received is placed at the area of interest. The position and radiation measurements can be conducted from an external source in real time and thus we can devise strategies for radiation therapy to optimize the process.

¹This content is available online at <<http://cnx.org/content/m15757/1.2/>>.

The wireless detector should be extremely small, capable to transmitting data, linear radiation response characteristics, independent of beam direction [5]. This module will be placed internally at the tumor. The potential candidates for the radiation measurement are obtained by filtering them on the basis of device materials, doping levels, working voltages and currents. The main feature to look for in this device is a high sensitivity to radiation. Different materials like silicon, GaAs, are considered. The test protocols and testing environment were designed to minimize the variations of the device characteristics to temperature, humidity etc. The CMOS device characterization was conducted statistically. The ideal CMOS device properties were discerned. An appropriate circuitry has been used to convert the change in the device parameters which is a measure of the radiation level to digital form.

These digital signals were sent wirelessly through a serial RFID communication channel. The system includes a remote receiver in wireless communication and is configured to receive the transmitted sensor data. The receiver is positioned external to the subject. The system should accommodate a data processor which is configured to receive the transmitted data, data correction when environmental effects in subject are changing [8].

2. Hypothesis:

The change in the MOSFET transistor characteristics when exposed to radiation can yield a reliable radiation sensing scheme. The various properties of the transistor such as the threshold voltage, resistance of the channel etc change with the radiation dose. This change can be effectively transmitted using a radio frequency communication. The signal obtained at the receiver can be processed and radiation received by the target transistor can be calculated.

The Gamma rays are produced from linear particle accelerator. A linear particle accelerator is used for accelerating the subatomic particles. These highly charged particles produce electromagnetic energy like photons. The interactions of these particles with the material in turn produce the gamma rays.

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Chapter 2

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Design/Implementation¹

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Design/Implementation

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3. 1 Radiation Effect on MOSFET

A metal-oxide-semiconductor field-effect transistor (MOSFET) operation is based on the control of charge concentration using MOS capacitance between a body electrode and a gate electrode located above the body and insulated from all other device regions by an oxide. The MOSFET terminals consist of a drain, source, gate and body. The drain and the source terminals are connected to individual highly doped regions that are separated by the body region. The NMOS source and drain regions are 'n+' regions and the body is a 'p' region. The PMOS source and drain regions are 'p+' regions and the body is a 'n' region. The basic structure of a NMOS device is shown in Fig.1.

The device operates in three regions of operation as shown in Fig. 2

¹This content is available online at <<http://cnx.org/content/m15758/1.2/>>.

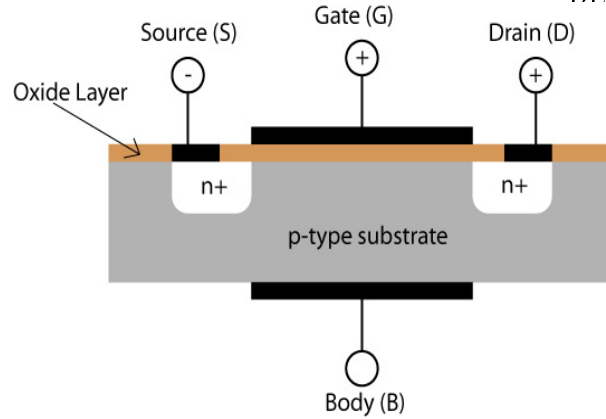


Figure 2.1

Cut-off ($V_{gs} < V_{th}$)

When the gate to source voltage of the transistor is below the threshold voltage of the device, the conduction layer below the gate is not formed as a result there is no conduction in this region ideally. In reality there is a small leakage current through the device. Fig. 1

- Linear ($V_{ds}-V_{gs} < V_{th}$)

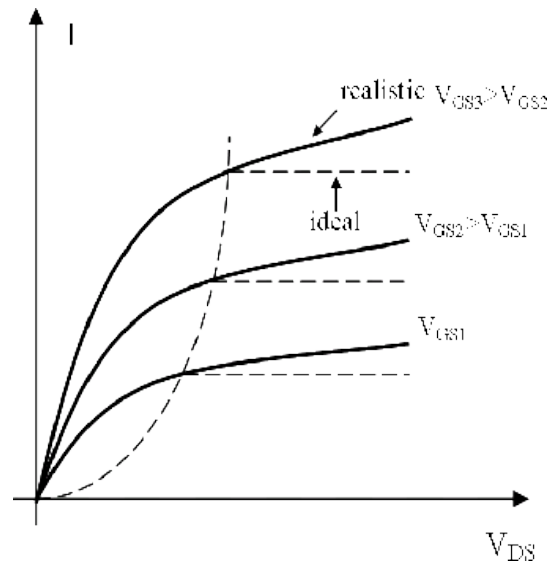


Figure 2.2

The linear mode of operation is reached when the gate voltage is above the threshold voltage and the channel is formed. The conduction current increases linearly with the applied drain to source voltage (V_{ds}). The device behaves as a linear resistor.

- Saturation region ($V_{ds}-V_{gs} > V_{th}$)

An increase in the Vgs voltage increases the current to a large extent and due to the electronic collisions in the channel between the electrons and the atoms the speed of the electrons cannot increase above a certain level. This causes the current in the channel to saturate. Thus even when a higher Vds is given the current increase is not linear. Fig. 2

Fig.3 ***SORRY, THIS MEDIA TYPE IS NOT SUPPORTED.*** The ionizing radiation damage in MOS devices results from electron hole pair generation from breaking of silicon-oxygen bonds in the gate of the transistor (SiO2). This produces the build up of trapped positive charges (mainly Holes) in the insulator and negative charges are concentrated at the insulator-channel interface [10]. The electrons are swept out by the bias voltage at source and drain. As shown in figure 3.

The positive charge build up in the silicon dioxide gate layer adjacent to the channel causes the threshold voltage of the NMOS to reduce in magnitude and increase in magnitude for the PMOS transistor [10]. In a NMOS the trapped positive charges migrate towards the silicon-silicon dioxide interface (Positive Gate Bias) but in PMOS they migrate towards the metal gate electrode (negative gate bias).

The trapped charges cause the energy bands to bend. In the normal state, the Fermi levels in the silicon and insulator are equal. Thus there is an electrostatic potential difference from one region to the next. The amount of energy required to extract an electron out of the material from its Fermi level is known as the work function. The gate bias voltage is required to restore the energy bands to their flat band voltage (Vfb). The threshold voltage equation for a MOSFET is given by the equation 1.

.....Eq. 1

$$V_T = V_{FB} + V_C + 2\phi_F + \frac{\sqrt{2\epsilon_s q N_a (2\phi_F + V_{SB} + V_C)}}{C_{ox}}$$

Figure 2.3

Fig. 4 ***SORRY, THIS MEDIA TYPE IS NOT SUPPORTED.*** Thus the threshold voltage is linearly proportional to the flat band voltage. The experimental results show that the flat band voltage shift is linear to the radiation received by the device. The threshold voltage change is more when thicker oxide is used. Thus the sensing device should have thicker oxide for a better radiation resolution. The change in the threshold shift is shown in the figure 4. The threshold voltage of the NMOS reduces in magnitude and increases in magnitude for the PMOS transistor [10]. The PMOS device has a negative Vth. For very high radiation dosage the Vth shift for an NMOS is towards higher Vth which produces the device rebound phenomenon. Since the target dosage of the application is below 7000CGy. This effect can be ignored.

3.2 Radiation Test Set-up

A linear accelerator was used to irradiate the transistors. The gamma rays attenuation by the human body can be modeled accurately by water. The brown block shown in the figure 5 has a density equal to water and can be used to model the human body. The DUT is placed on a skin like insulator to simulate the real skin tissue. The MOS transistors are very sensitive to static discharges thus by placing the devices in the insulator helps in shielding the gate terminal from possible discharge. The increase in the temperature of the radiated area is minimal during radiation. The humidity is fairly constant. The Test setup is shown in the figure 5. The transistors are sandwiched between two brown blocks. The thickness of each block is 5cm. Thus the transistors can be considered as being placed 5cm under the skin.



Figure 2.4

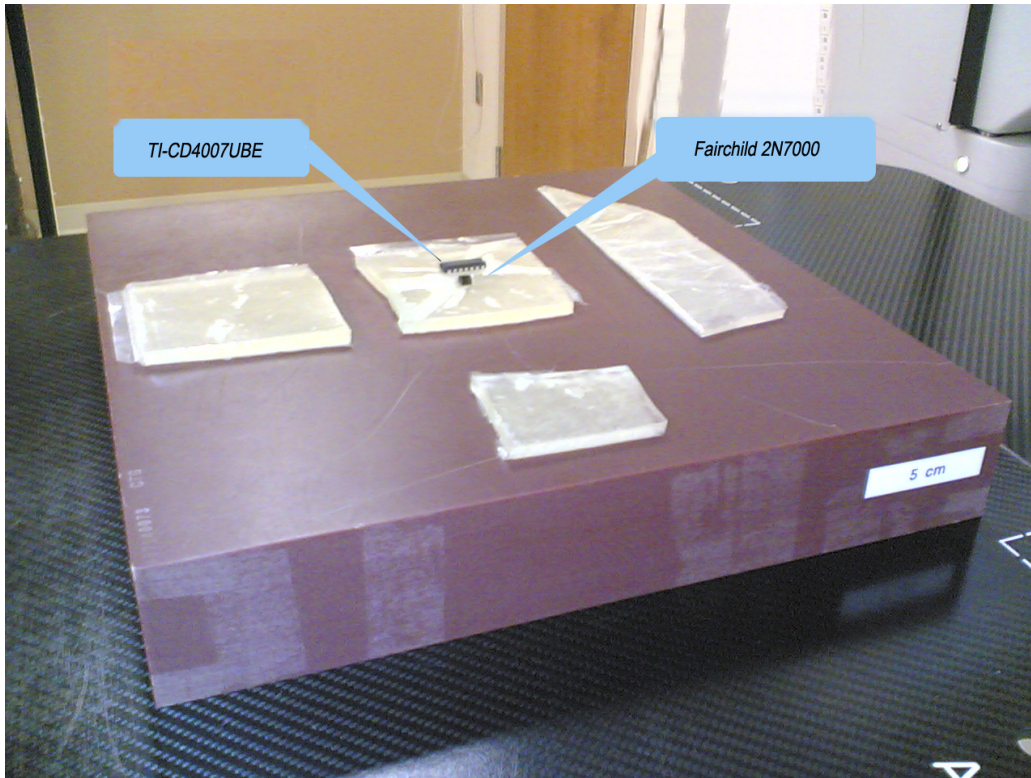


Figure 2.5

Fig. 5

The same test setup is used for irradiating all the transistors. The transistors are irradiated with the following specifications.

- Area of the Radiation beam : 10cm x 10cm
- Depth under the skin : 5cm
- Beam Energy : 6MV

Dose (CGy)	Rate of Dose (MU/min)	Monitor Units(MU)
100	361	117
1000	354	1170
3000	359	3513
5000	375	5855

Table 2.1

Table 1

The Devices under test are TI-CD4007UBE and Fairchild 2N7000 (N-Channel Enhancement Mode Field Effect Transistor). These products have been selected because of their specifications such as minimum on-state resistance, rugged, reliable, and fast switching performance. For each radiation dosage two chips of each type are used to consider the effects of inter-device variations.

4. MOSFET Characterization

Fig. 6

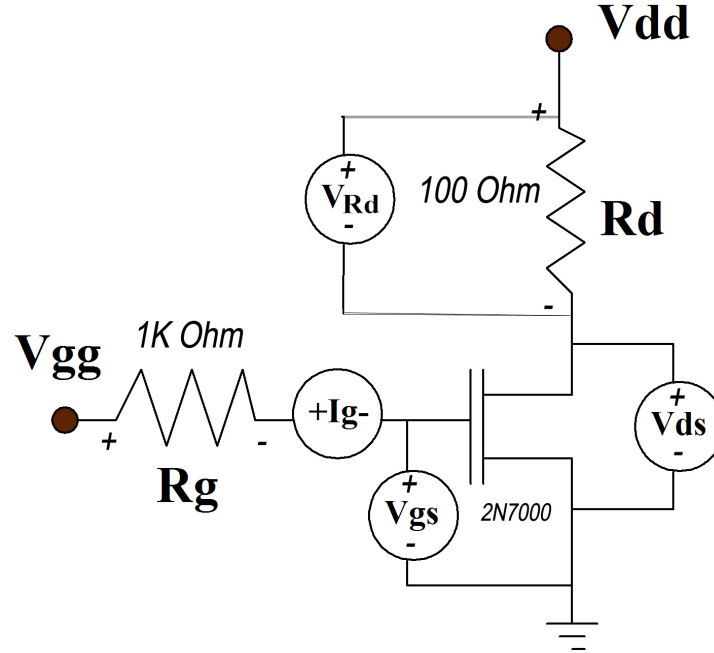


Figure 2.6

The purpose of MOSFET characterization is to obtain the device operating curves accurately and estimate the transistor parameters. The characterization is performed on the transistors before and after radiation. The Test setup for this process is shown in the figure 6. Two DC generators are used for V_{dd} and V_{gg} . The gate current is measured by an ammeter I_g . The voltages V_{gs} (across gate and source) and V_{ds} (across drain and source) are measured using two multimeters V_{gs} and V_{ds} respectively. A resistance R_g of 1k ohm is in series with the gate circuit to protect the device from high currents. A resistance R_d is placed in series with the drain to source circuit to limit the saturation current. This resistance needs to be changed accordingly to obtain desired transistor operating curves. This value is changed from 30 Ohms to 1K Ohm.

Fig. 7

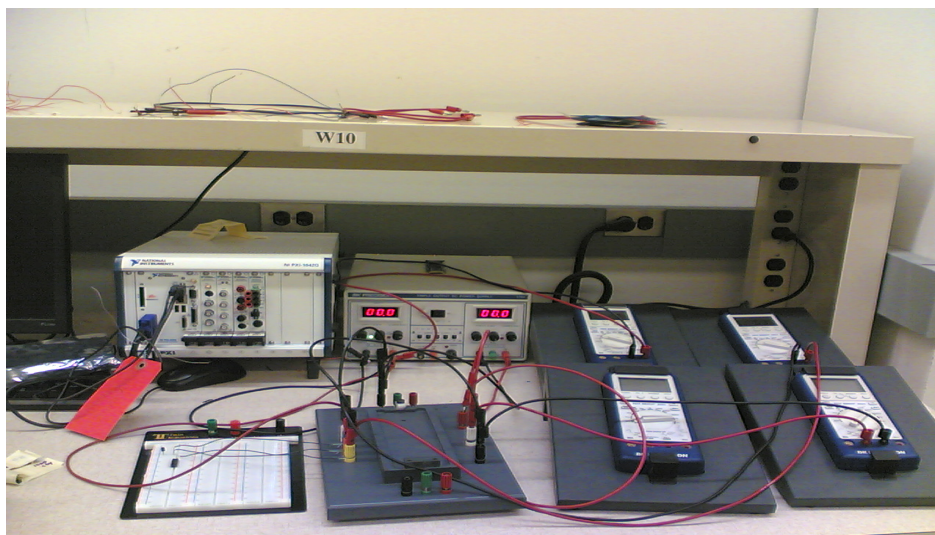


Figure 2.7

The voltage V_{gg} is set at three values 2V, 3V and 5V. The voltage V_{dd} is varied from 0V to 8V for each value of V_{gg} . The readings V_{gs} , I_d , V_{ds} and V_{rd} are noted down for each iteration. The setup for the characterization is shown in the figure 7.

The inter-device variation was found to be minimal in the devices. The error in readings between the devices was less than 1%. The curves obtained for different radiation dosages are presented in the figure 8.

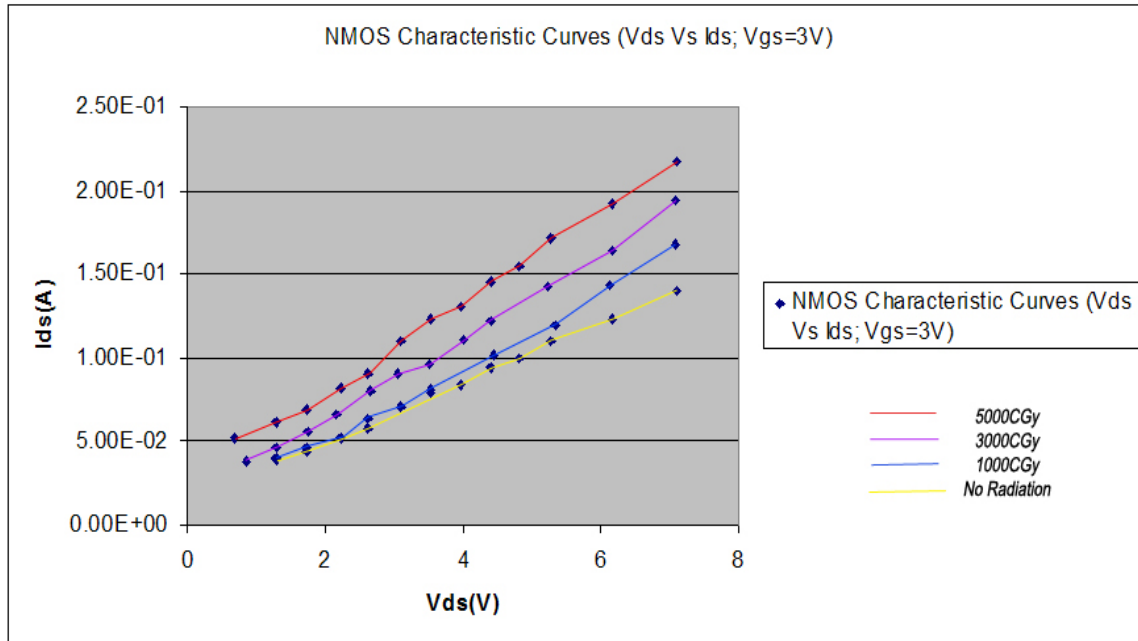


Figure 2.8

Fig. 8

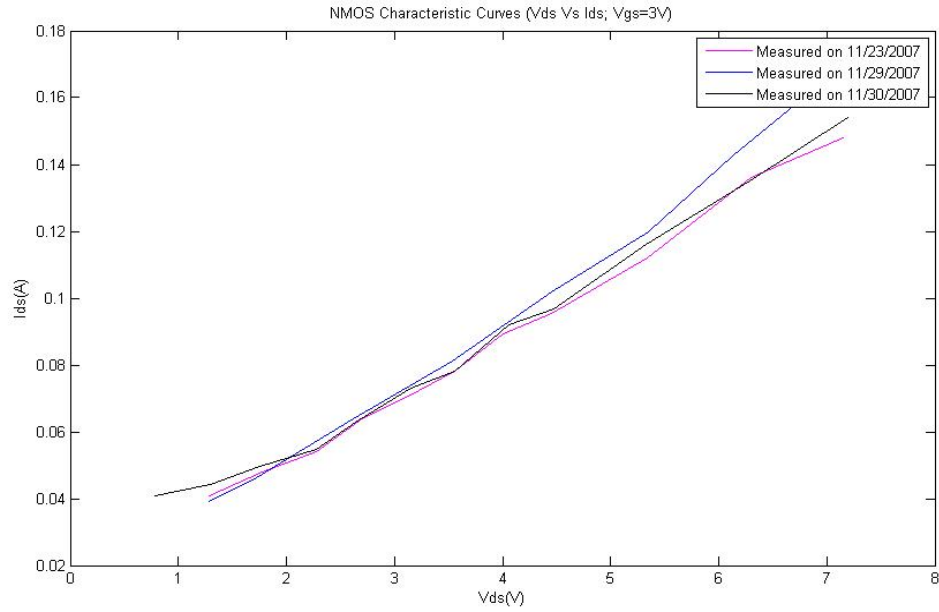


Figure 2.9

The curves shifted up with an increase in radiation dose. The radiation dose caused the threshold voltage of the NMOS to reduce. This phenomenon can be seen clearly from the curves. For a Given V_{ds} the current obtained is increasing. The theory behind this operation is explained in the above section. Since the theory supports the test data PMOS transistor was also tested for the same. A NMOS Transistor was irradiated on November 23, 2007. The V_{ds} and I_{ds} curves of this transistor was measured on November 23, 2007, November 29, 2007 and November 30, 2007. The change over time was very negligible. The maximum change of current (I_{ds}) for a particular V_{ds} was below 7%. The results obtained are presented in figure 9.

Fig. 9

Fig. 9

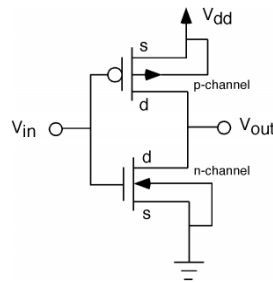


Figure 2.10

5. Radiation Sensing Scheme

Fig. 10A CMOS inverter consists of a PMOS and a NMOS transistor arranged in a configuration as

shown below. The schematic diagram of an inverter is shown in figure 10. The drain terminal of the PMOS and NMOS transistor are connected together.

Principle of Operation:

- When the input voltage to the terminal V_{in} is low, the PMOS transistor is turned ON and the NMOS transistor is turned OFF and output is connected to the terminal VDD via PMOS.
- When the input voltage to the terminal V_{in} is high then the transistor NMOS is turned ON and V_{out} is pulled to GND potential.
- Consider the terminal V_{in} is supplied with a saw-tooth waveform. When the voltage slowly rises from 0 to Vdd the PMOS is initially turned ON and when the voltage rises above the threshold voltage of NMOS then NMOS turns ON and PMOS is turned off pulling the voltage at V_{out} to GND. When the voltage drops from Vdd to 0V NMOS is initially turned ON and when the voltage reached the PMOS threshold voltage NMOS turns OFF and PMOS is turned ON.
- The switching point voltage is defined as the voltage at which $V(V_{in}) = V(V_{out})$. The switching voltage is denoted by V_m .

The threshold voltage of the NMOS decreases and PMOS increases with radiation. The switching voltage V_m changes with an increase in radiation. The change in the switching voltages is tabulated in the table 2.

Dosage (CGy)	Output (0-1)	Output (1-0)
0	4.969	5
1000	4.875	4.719
3000	4.656	4.594
5000	4.375	4.375

Table 2.2

Table 2

The switching voltage V_m during a transition from 0 to 1 or 0V to 5V at terminal V_{out} is given by Output (0-1). The switching voltage V_m during a transition from 1 to 0 or 5V to 0V at terminal V_{out} is given by Output (1-0).

An increase in radiation dose causes the pulse width of the waveform at the output V_{out} to decrease as shown in the figure 11. The switching voltage of the inverter under radiation is modeled in HSPICE. The green waveform represents the voltage at the output V_{out} for a normal inverter pair. The yellow waveform represents the voltage signal at the output V_{out} for a radiated inverter pair. The pulse width of the waveform is reduced due to radiation effect. Thus this signal is sent to a RF chip through a capacitor (100pF) and the waveform at the output gives a measure of the radiation received by the inverter pair.

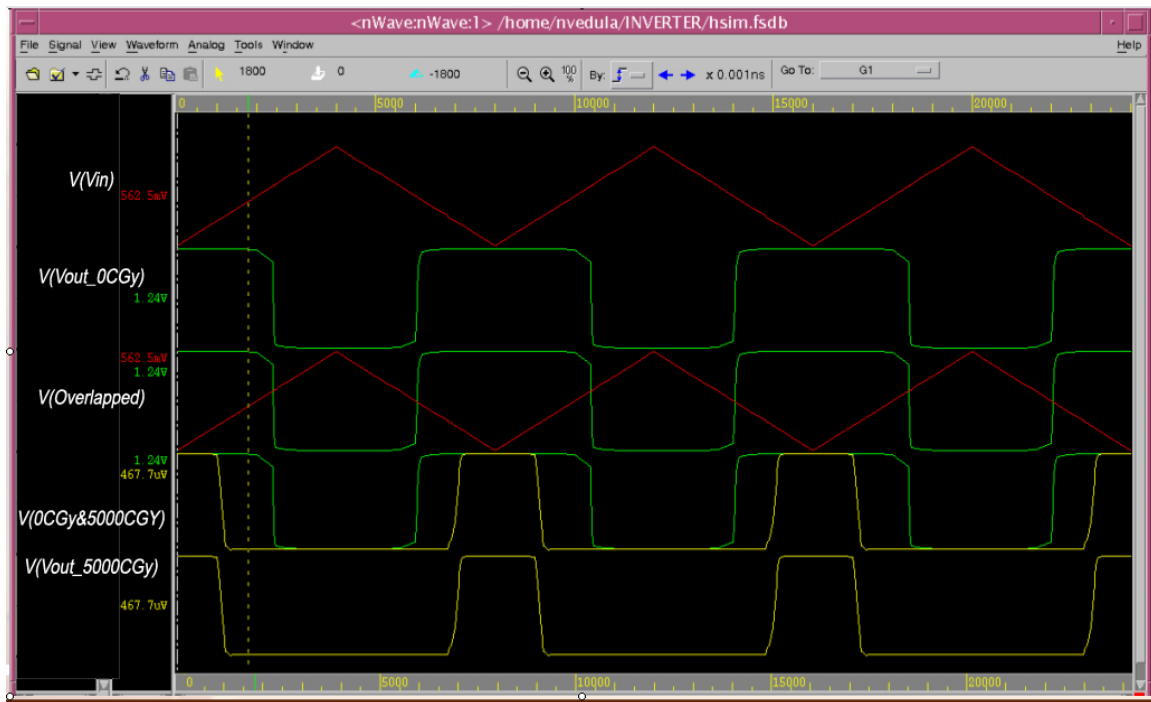


Figure 2.11

Fig. 11

6. RF Transmitter and Receiver:

The design of a reliable wireless transmitter and receiver pair is an essential step in being able to carry out the radiation dose assessment. In the proposed detector system, an RF transmitter will be placed along with the miniature bio-compatible radiation sensor and an RF receiver will be located external to the human body along with an electronics package containing the data collection and calibration unit.

As a proof of concept, we chose an off-the-shelf RF transmitter and receiver pair that meets our specifications. We selected TXM-916-ES (RF transmitter), RXM-916-ES (RF receiver) of Linx technologies and ANT-916-CHP-x Chip antennas from Antenna Factor for our experiment. These devices offer the advantages of 1) Ultra compact SMD packaging, 2) FM/FSK modulation for noise immunity, 3) Excellent sensitivity for outstanding range, 4) Wide range analog capability, 5) High data rate (maximum 56kbps) and 6) Cost effectiveness. They also provide useful features such as audio reference, low voltage detect and level adjustment. These modules require no tuning or any other external RF components. They operate in the 900MHz frequency band. Fig 1 illustrates the pin connections of both transmitter and receiver modules.

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Figure 2.12

Image not finished

Figure 2.13

Fig. 12(i) Fig. 12(ii)

The output analog signal of the radiation sensor (within the specified audio bandwidth) is connected directly to the transmitter's DATA line. The transmitter input is high impedance ($500k\Omega$) and can be directly driven by the sensor output signal. This analog source provides no more than 5VP-P maximum waveform (within the input level) and is AC-coupled into the DATA line. The size of the coupling capacitor is selected to be large enough to ensure the passage of our signal frequencies of interest. Since the modulation voltage applied to the DATA line determines the carrier deviation, distortion can occur if the DATA line is over-driven. So, the actual level of the input waveform is adjusted to achieve optimum in-circuit results.

The receiver, RXM-916-ES, is capable of receiving a signal as low as -97dBm (typical). The signal is filtered at its front end by a SAW band-pass filter. The filtered signal is then amplified and down converted to the IF by mixing it with a LO frequency generated by a PLL-locked VCO. The IF is then amplified and filtered. Finally, a PLL demodulator is used for recovering the baseband analog signal from the carrier. The ES receiver features an on-board data slicer for recovery of data transmission. Its output is internally derived from the filtered analog baseband, which is squared and made externally available on the DATA line. The data slicer is capable of recreating squared waveforms from 100Hz to 28 kHz, giving a data rate bandwidth of 200bps to 56kbps.

1/4-wave Monopole Chip antennas based on advanced Low Temperature Co-fired Ceramic (LTCC) technology are used to transmit and receive the modulated data on both the sides of transmitter and receiver. These antennas are ideal with excellent electrical specifications delivering 50Ω characteristic impedance.

As explained in the previous section, the voltage signals with the frequencies 50Hz, 80Hz and 100Hz and peak-to-peak voltage 5V are given as input to the sensor. The output signals (inverted) from the sensor are connected to the DATA line of the RF transmitter. At the transmitter side, the modulated analog data is transmitted using a chip antenna. The data is received at another chip antenna on the receiver side which is then demodulated and made available at the DATA line of the RF receiver.

7.1 LabVIEW Setup:

The National Instruments LabVIEW graphical development environment helps in creating flexible and scalable design, control, and test applications. The LabVIEW VI is designed to use a National Instruments DAQ (Data Acquisition) card with the model NI-6251E and the screw terminal connector blocks with the model CB-68LP. The first part of setting up the hardware is to wire up the connector block for two analog inputs.

The output data of RF receiver is connected the analog input channel #2 (AI-2). The receiver GND pin is connected to the analog input gnd (AI-GND). User inputs can be taken to set the sampling rate and sample display rate. The sampling rate is set at the maximum value of 24,000 samples/sec and the display rate is set at 50 samples/sec. We can start the LabVIEW 'Receiver_data.vi' by clicking on the Run button on the toolbar. Data that is being read from the analog input channel will appear on a graph.

To store the results in a spreadsheet file, 'Save data' knob needs to be turned on. By default the data is stored in a file 'radiation_rfddata.xls'. After collecting enough of data into the spreadsheet, process can be halted by clicking on the same knob again. Green LED indicates that the data can be saved to a file and a red LED indicates that the saving is in progress. The spreadsheet file can be opened to examine the contents. There should be two columns of data, with a measurement point on each row. The column values are Time (sec) and output voltage read from the RF receiver DATA line (V).

The data is collected for different input signal frequencies (50Hz, 80Hz and 100Hz) and different radiation sensors with varied dosages (100CGy, 1000CGy, 3000CGy and 5000CGy). Each time after saving the data to a file, it is renamed to radiation_rfddata_<freq>_<dosage>.xls' to further use them in calibration.

7.2 Data Analysis:

After saving the data to a spreadsheet file, it is analyzed to understand the radiation effects on MOS transistors. As explained before, due to the changes in sensor (inverter) characteristics with radiation, the On-time of the output signal should decrease and the Off-time of it should increase with a corresponding raise in radiation dosage. The lower the input frequency, the higher the difference in on and off times of the output signal (with increase in radiation dosage). So, the input frequencies are chosen as 50Hz, 80Hz & 100Hz. This frequency cannot be lowered further because of the limitation of data slicer in RF receiver which works better for creating the squared waveforms from 100Hz to 28 kHz. So, this introduces noise for the signal frequencies 50Hz and 80Hz.

Using Matlab the signal noise based on its spectral characteristics was eliminated. First, the data is read from a file which is obtained from the LabVIEW program. The 512 point FFT is performed on the signal to get its power spectral plots. The plots show that there is a DC component and few unwanted high frequency signals in the spectra. So, a notch filter centered at 0Hz frequency (with a very low bandwidth) is used to eliminate the DC component. Also, a low pass filter with a cut-off frequency of 1000Hz is used to remove all the undesired high frequency components. This cannot be reduced below 1000Hz, as it causes distortion to the signal. The actual and filtered signal plots are illustrated in Fig. 13. Also, a sample power spectrum plot for a 100Hz input signal is shown in Fig. 14.

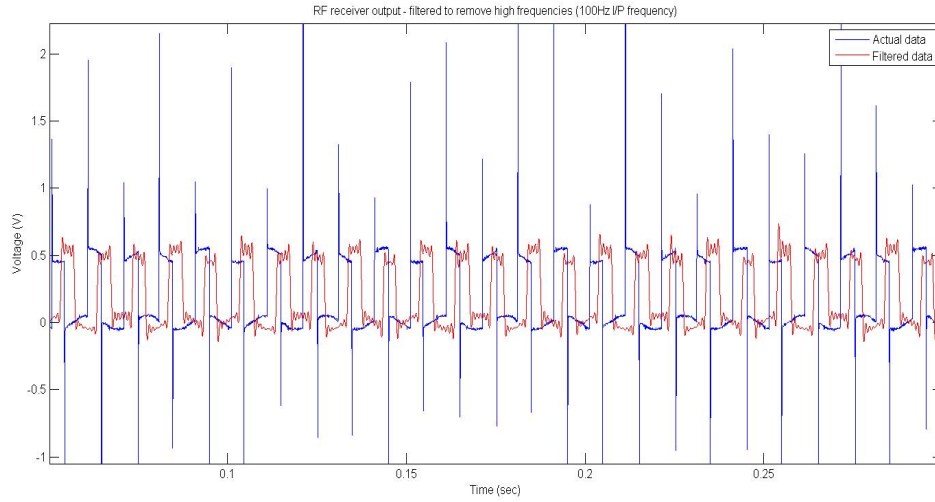


Figure 2.14

Fig. 13

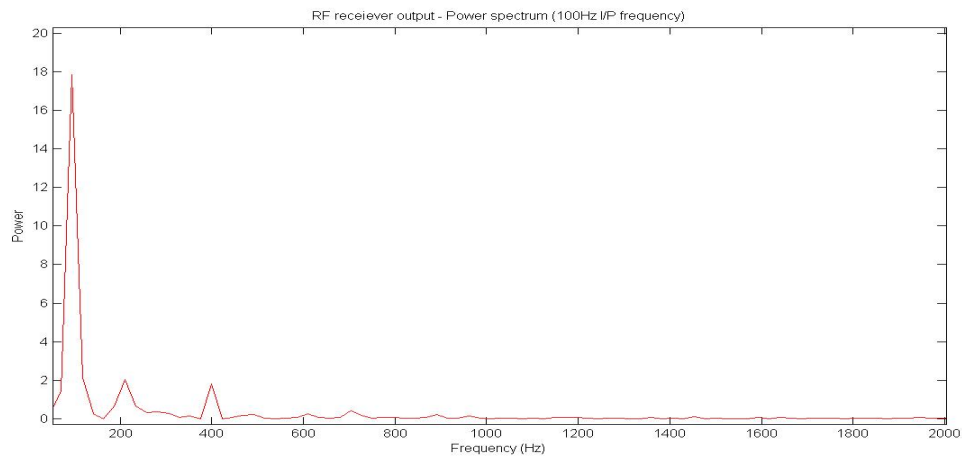


Figure 2.15

Fig. 14

After filtering, few spikes still exist in the low frequency signals. The filtered signal is converted to a square wave (from 0 to 5V) based on minimum and maximum limits of 1V and 4V respectively. In this square wave, the times of first zero-to-one and one-to-zero transitions are measured in the non-spike regions. The averages of On and Off times are taken over the entire signal region to get a valid estimate of these values. An approximated square waveform is shown in the Fig 15.

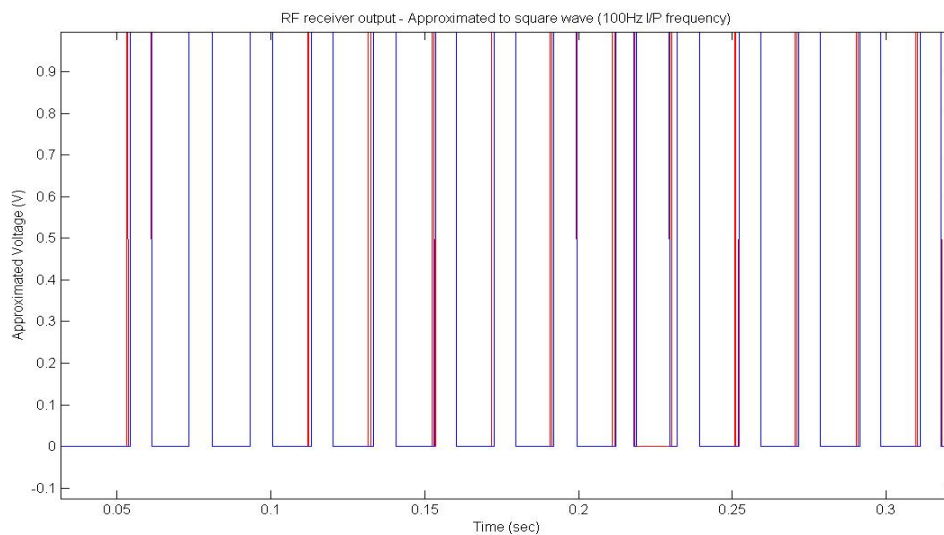


Figure 2.16

Fig. 15

With these filtering and analysis techniques, a good measure of the On and Off times of the signal was observed. This sequence is followed for the data of all input signals collected from the LabVIEW program for all the combinations of frequencies and radiation dosages.

7.3 Calibration Algorithm:

The On time and Off time values for different radiation dosages (100CGy, 1000CGy, 3000CGy and 5000CGy) are plotted in Table 3, for different signal frequencies (50Hz, 80Hz and 100Hz).

These plots illustrate the linear change in timing values with respect to radiation dosages. All the timing values for these combinations are stored in the file, 'calibration.xls'. The measured On and Off time values are illustrated in the below table. We can clearly observe a decreasing trend in On times and an increasing trend in Off times. This data can be used to estimate the unknown dosage of an irradiated sensor (CMOS inverter). Using Matlab, the calibration data is read from the spreadsheet file. For a specific input frequency, if the measured timing values (On and Off times) lie between the corresponding values of two consecutive dosages, the unknown radiation dosage is calculated by linearly interpolating these known dosages.

Frequency (Hz)	Radiation Dose (Cgy)	On Time (sec)	Off Time (sec)
50	0	0.0077	0.0122
	1000	0.0068	0.0127
	3000	0.0065	0.0132
	5000	0.0062	0.0135
80	0	0.0045	0.0081
	1000	0.0044	0.0081
	3000	0.0043	0.0082
	5000	0.0041	0.0083
100	0	0.0067	0.0036
	1000	0.0067	0.0037
	3000	0.0065	0.0037
	5000	0.0064	0.0038

Table 2.3

Table 3: Change in On and Off time values of sensor output with radiation

The overall setup is tested with few intermediate dose values (2000CGy and 4000CGy) and obtained the accurate results. As the range of difference in timing values is very less, it is very difficult to estimate the dosages exactly with smaller resolutions.

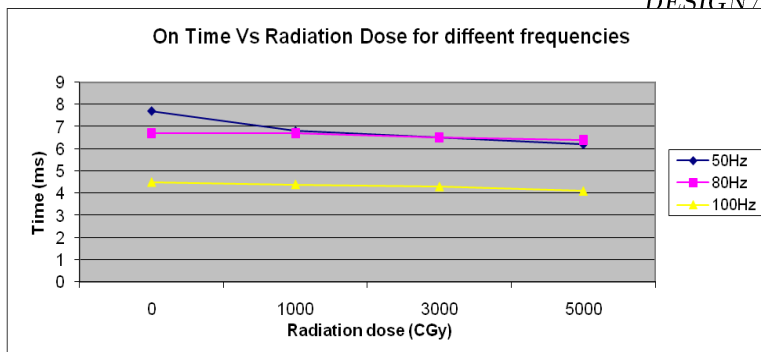


Figure 2.17

Fig. 16

8.1 Design for Powering up the Sensor:

The Implantable Micro Devices (IMDs) need continuous power from the external world. This can be achieved by connecting a power and data cable, breaching the skin, to the IMDs. This causes the sensitive body tissues to be exposed to the environment resulting in infections. Another method is to power the IMDs using batteries which need to be replaced after a certain period of time. This requires periodic surgery, further increasing risk as well as financial burden on the part of the user.

An alternative to these solutions is wireless transmission of power. This can be achieved by an inductive link between two magnetically-coupled coils. It is now one of the most common methods to wirelessly transmit power from the external world to IMDs. One of the primary requirements in such a system is that the inductive power transmission should be very efficient to minimize the size of the external portable battery, and eliminate overheating of the surrounding tissue by surpassing the exposure limit to electromagnetic field.

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Figure 2.18

Fig. 17

8.2 Power Transfer:

Transmitter -

The transmitting power through inductively coupled coils requires an AC excitation which in turn makes the power driver to be a DC to AC inverter. Furthermore, a high voltage level is usually required by the primary coil (approx. 80-100V).

For this, a Class-E power amplifier should be chosen to drive the transmitter coil with high efficiency (i.e., 90–95%). Class-E power amplifier drives the primary coil L1, which is coupled to the implantable coil L2. In this amplifier, a choke inductor provides constant dc current with a high-speed switching power MOSFET operating around at 500-kHz frequency, driven by the Class-E driver.

Receiver -

On the receiver side, Cr forms a resonant tank with the receiver coil L2. A bridge rectifier converts the AC signal on the receiver-tank circuit to provide a DC voltage. A low drop out regulator supplies a constant 5V supply from the output of the rectifier. This is the VDD to all the other circuitry on the implantable device side.

9. Bio Compatibility;

The use of biocompatible materials is important in determining the longevity of chronically implantable sensors. Protein adsorption is the initial event that takes place once an implant is in the body. These adsorbed proteins are then a significant influence on the subsequent adsorption of further proteins and cells. So, they dictate the interfacial reactions and ultimately biocompatibility of the material. Parylene-c and Polydimethylsiloxane (PDMS), Polypyrrole (PPY) are few materials which are biologically inert and can be used in preventing protein adsorption, a characteristic required for any implantable sensor. The device should be coated with these biocompatible passive materials which provide electrical isolation to the active areas of each array element and protect it from corrosive environments. The coating must also provide good mechanical characteristics. The observed lifetimes of the devices coated with these materials are sufficient for long-term use inside the human body. Apart from testing in air, these coated devices should also be

tested in underwater using pulse excitation. ***Image not finished***

Chapter 3

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Conclusions/Future Work/References¹

Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector - Conclusions/Future Work/References

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University of Minnesota- Twin cities

10. Conclusions:

The effect of radiation is studied on different MOS devices. The threshold voltage of a MOS transistor decreases with a raise in radiation dosage because of the trapped holes in oxide region. For an NMOS transistor, absolute value of V_t goes down making it to conduct easily, while for a PMOS transistor it works in the other way. We can make use of this cumulative effect by studying the behavior of an inverter. The On time of an inverter decreases with radiation dosage and while the Off time increases with it. With a lower frequency input signals, the range of difference in timing values can be increased. The sensor output signal is transmitted wirelessly using a transmitter/receiver pair. The receiver data signal is obtained and plotted using a DAQ (Data Acquisition) card and a LabVIEW program. The sampled data is filtered to remove the DC and undesired high frequency components. The On and off times for different radiation doses and signal frequencies are used to calibrate and measure an unknown radiation dosage value. It is also observed that the irradiated device characteristics do not change with time.

Finally, this project implements the idea of measuring radiation dose in terms of changes in MOS transistor characteristics. Since all of the processing is done at the receiver side, no complex circuitry will be placed next to the sensor (except an RF transmitter). With this the power and size requirements will be lot lesser than other commercialized devices. As the sensors are not custom-made devices, the results did not render high resolution.

11. Future Work:

In this project, we can observe that the timing measurements show a smaller range for the total range of radiation dosages. So, custom-made MOS transistors can be used to improve this range and also the resolution to a greater extent.

The whole design should be fabricated into mm wide ICs which can be implanted inside human body. This is achievable with today's nano scale fabrication technologies. Also the RF transmitter should reside on the same chip along with the sensor. For this, an elaborated design of the transmitter is required.

¹This content is available online at <<http://cnx.org/content/m15759/1.2/>>.

Apart from the sensor, no other device should be affected by radiation. Specialized SOI (Silicon On Insulator) or SOS (Silicon on Sapphire) fabrication techniques provide embedded protection against the radiation damage. With this, normal commercial-grade chips can withstand between 5 and 10K CGy which is far above the working range of our sensor.

As the On and Off time values of sensor output depend on the input signal frequency, a radiation sensor array network can be designed in such a way that each sensor in the array operates at a specific frequency. All these signals can be transmitted wirelessly and processed at the receiver side (by using a DSP circuitry) to obtain each sensor's output signal characteristics separately.

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Image not finished

Figure 3.1

²<http://www.tc.umn.edu/~vadla005/Papers/A%20Comparative%20Study%20of%20Gamma%20Radiation%20Effects.pdf>

³<http://www.tc.umn.edu/~vadla005/Papers/Gamma%20Radiation%20Nose%20System%20Based.pdf>

⁴<http://www.tc.umn.edu/~vadla005/Papers/Modelling%20Radiation%20Induced%20Burnout%20in%20DMOS.pdf>

⁵http://www.tc.umn.edu/~vadla005/Papers/Briere_Sicel_2005.pdf

⁶<http://www.tc.umn.edu/~vadla005>

Index of Keywords and Terms

Keywords are listed by the section with that keyword (page numbers are in parentheses). Keywords do not necessarily appear in the text of the page. They are merely associated with that section. *Ex.* apples, § 1.1 (1) **Terms** are referenced by the page they appear on. *Ex.* apples, 1

A Abstact, § 1(1)

detector, VLSI, MOSFET, § 2(3), § 3(21)

I In-vivo Radiation therapy, § 1(1)
In-vivo, Radiation measurement, Wireless

M MOSFET, § 1(1)

V VLSI, § 1(1)

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Design of an In-Vivo Radiation Measurement Scheme Using a Reliable Wireless Detector

The purpose of this project is to develop a method for monitoring, evaluating the status of a tumor undergoing radiation treatment and transmit the radiation dose received by the tumor in real-time to an external data acquisition unit and evaluate the treatment strategy. The target system to be designed would consist of a miniature wireless sensor module which would be implanted in the region of interest and this unit transmits the data to an external receiver wirelessly. The Modern fabrication process allows us to fabricate CMOS circuits in nanometer range which is highly desirable when used in radiation sensing scheme where size is the main constraint. The heart of the sensing system is a MOS transistor device. The electrical properties of the MOS device (drain to source resistance, threshold voltage) change when exposed to gamma radiation. The objective of this project is to evaluate the MOS transistor parameters change with radiation dose, study the effects with varying transistor widths, lengths and propose the ideal characteristics of the CMOS device. The scheme of the radiation measurement is presented. Some of the questions that will be addressed in this report are – The effect of radiation on channel resistance during & after radiation, temperature dependency of the radiation effects. The complete characterization of the sensor is performed and the results are produced and cross checked with device physics. The characterized CMOS transistor is exposed to radiation and the radiation dosage received by the transistor is sent to a RFID receiver using radio frequency communication. The signal at the RFID receiver is filtered and the actual radiation dosage was determined from the filtered output's duty cycle. A novel approach is used in determining the radiation measurement in this study.

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